Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/677,228	MATSUURA ET AL.	
Examiner	**Art Unit**	
German Viana Di Prisco	2617	

SEARCHED			
Class	Subclass	Date	Examiner
370	535	2/15/2008	GV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Image and keybpoard search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	2/15/2008	GV
Inventor and Assignee search in PALM ExPO and EAST	2/15/2008	GV
EPO Database(http://ep.espacenet.com)	2/15/2008	GV
www.jpo.go.jp	2/15/2008	GV
Consulted with Ken Vanderpuye and Duc Nguyen	2/15/2008	GV
((time near (period zone window block length region interval bracket section frame)) or time or (period zone window block	2/15/2008	GV
length region interval bracket section frame)) with (measur$4 calculat$4 determin$4) with (audio near rate)	**2/15/2008**	**GV**